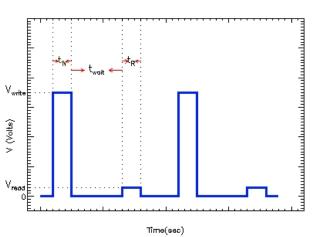
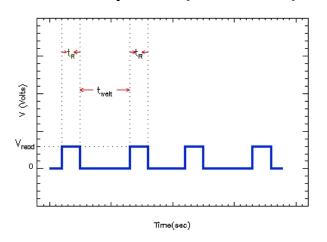
+Write & Read pulses:

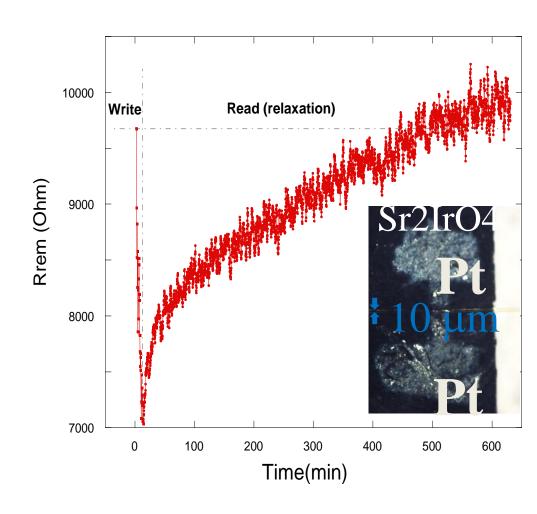


Write: 3.5V - 1s / twait=5-80 s

Read: 1V – 10 ms

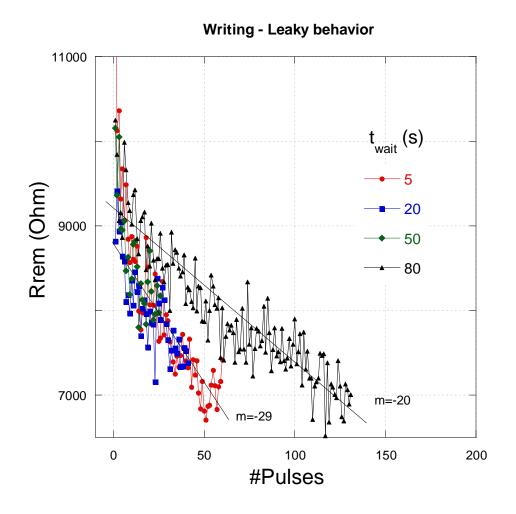
+Read pulses (relaxation):





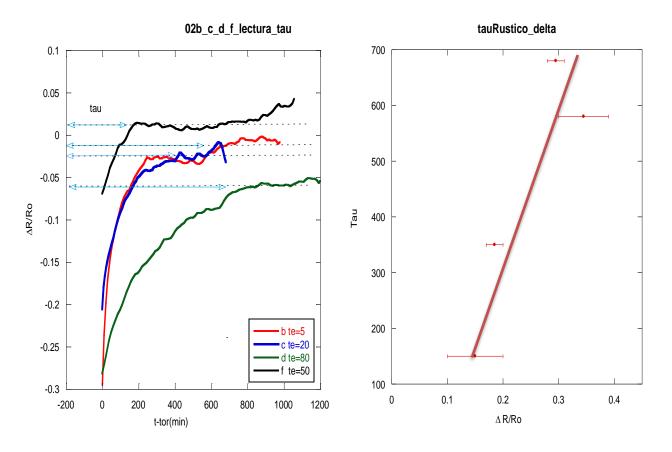
- -Cummulative effect of the write pulses
- -Long relaxation (volatility)

Relaxation studies: t_{wait} effect on writing



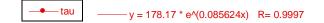
A leaky behavior can be observed

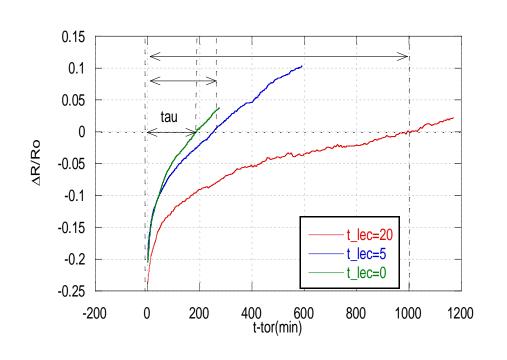
Relaxation studies: twait effect on writing

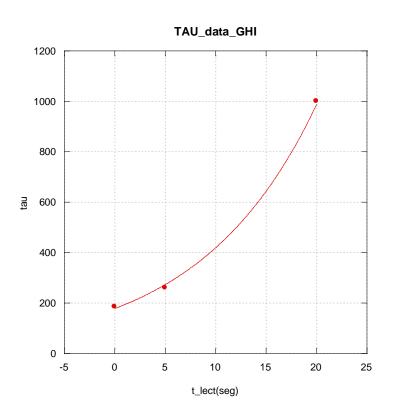


Tau increases with increasing resistance change (ie with increasing the filament width)

Relaxation studies: twait effect on reading







The frequency of reading pulses affects the relaxation process. Decreasing twait between readings reduces the relaxation time